

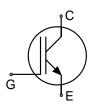
IGBT3 Power Chip

Features:

- 1700V Trench & Field stop technology
- low switching losses and saturation losses
- soft turn off
- positive temperature coefficient
- easy paralleling
- Qualified according to JEDEC for target applications

Recommended for:

- power modules
- **Applications:**
- drives



Chip Type	V _{CE}	/ Cn ¹⁾	Die Size	Package
IGC136T170S8RH2	1700V	117.5A	17.72 x 7.7 mm ²	sawn on foil
1)				

¹⁾ nominal collector current at Tc = 100°C, not subject to production test - verified by design/characterization

Mechanical Parameters

		47.707.7		
Die size		17.72 x 7.7		
Emitter pad size (incl. gate pad)		See chip drawing		
Gate pad size		1.674 x 0.899		
Area total		136.4		
Thickness		190	μm	
Wafer size		200	mm	
Max.possible chips pe	er wafer	187		
Passivation frontside		Photoimide		
Pad metal		3200 nm AlSiCu		
Backside metal		Ni Ag –system		
Die bond		Electrically conductive epoxy glue and soft solder		
Wire bond		Al, <500µm		
Reject ink dot size		Ø 0.65mm ; max 1.2mm		
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, Temperature 17°C – 25°C, < 6 month		
	for open MBB bags	Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert gas, Humidity <25%RH, Temperature 17°C – 25°C, < 6 month		



Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage, <i>T</i> _{vj} =25 °C	V _{CE}	1700	V	
DC collector current, limited by $T_{vj max}$	I _C	1)	A	
Pulsed collector current, t_p limited by $T_{vj max}^{2}$	I _{c,puls}	352.5	A	
Gate emitter voltage	V _{GE}	±20	V	
Junction temperature range	T _{vj}	-40 +175	<u>.</u>	
Operating junction temperature	T _{vj}	-40 +150		
Short circuit data ²⁾³⁾ $V_{GE} = 15V$, $V_{CC} = 1000V$, $T_{vj} = 150^{\circ}C$	t _{SC}	10	μs	

¹⁾ depending on thermal properties of assembly

²⁾ not subject to production test - verified by design/characterization

³⁾ allowed number of short circuits: <1000; time between short circuits: >1s.

Static Characteristics (tested on wafer), T_{vj} =25 °C

Parameter	Symbol	Conditions	Value			Unit
T arameter	Cymbol	Conditions	min.	typ.	max.	onic
Collector-Emitter breakdown voltage	V _{(BR)CES}	<i>V</i> _{GE} =0V , <i>I</i> _C =2 mA	1700			
Collector-Emitter saturation voltage	V _{CEsat}	V _{GE} =15V, <i>I</i> _C =35.25A	1.0	1.1	1.3	V
Gate-Emitter threshold voltage	V _{GE(th)}	$I_{\rm C}$ =4.7mA , $V_{\rm GE}$ = $V_{\rm CE}$	5.3	5.8	6.3	
Zero gate voltage collector current	I _{CES}	V _{CE} =1700V , V _{GE} =0V			7	μA
Gate-Emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$			300	nA
Integrated gate resistor	r _G			11.5		Ω

Electrical Characteristics (not subject to production test - verified by design / characterization)

Parameter		Symbol	Conditions	Value			L Incit
				min.	typ.	max.	Unit
Collector-Emitter saturation	<i>T</i> _{vj} =25 °C	V			1.75	2.2	V
voltage	<i>T</i> _{vj} =150 °C	V _{CEsat}	V _{GE} =15V, <i>I</i> _C =117.5A		2.2		V
Input capacitance		Cies	V _{CE} =25V,		10568		
Reverse transfer capacitance		C _{res}	V _{GE} =0V, <i>f</i> =1MHz <i>T</i> _{vj} =25 °C		340		рF



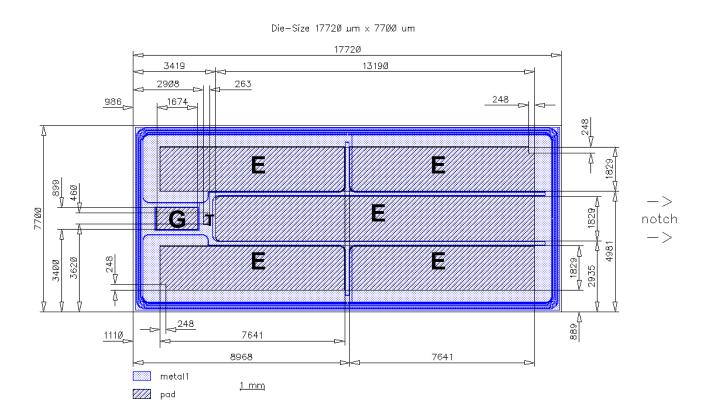
Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

This chip data sheet refers to the device data sheet	FF1400R17IP4	Rev. 2.2	
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Chip Drawing



- **E** = Emitter
- $\mathbf{G} = \text{Gate}$
- T = Test pad do not contact



Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Version	Subjects (major changes since last revision)	Date	

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